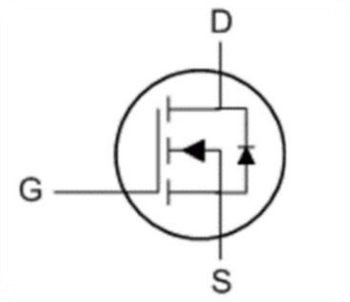
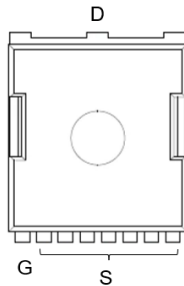


**Description**
**45V N-CHANNEL ENHANCEMENT MODE POWER MOSFET**
**Features**

- Device Rating  $V_{DS} = 45V$ ,  $I_D = 225A$
- $R_{DS(ON)} = 1.5m\Omega$  (typ.) @  $V_{GS} = 10V$ ,  $I_D = 20A$
- $R_{DS(ON)} = 2.0m\Omega$  (typ.) @  $V_{GS} = 4.5V$ ,  $I_D = 20A$
- Proprietary High Density Trench Technology
- RoHS Compliant & Halogen-Free

**Application**

- BMS
- ESS
- PD charger
- E-tool

**Package**


**TOLL**  
**JFG225N45Q**

**Absolute Maximum Ratings**  $T_C = 25^\circ C$  unless otherwise specified

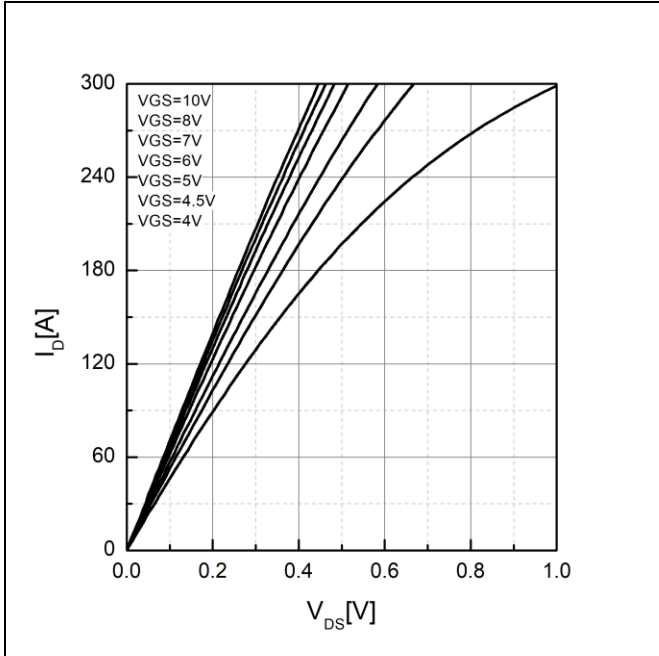
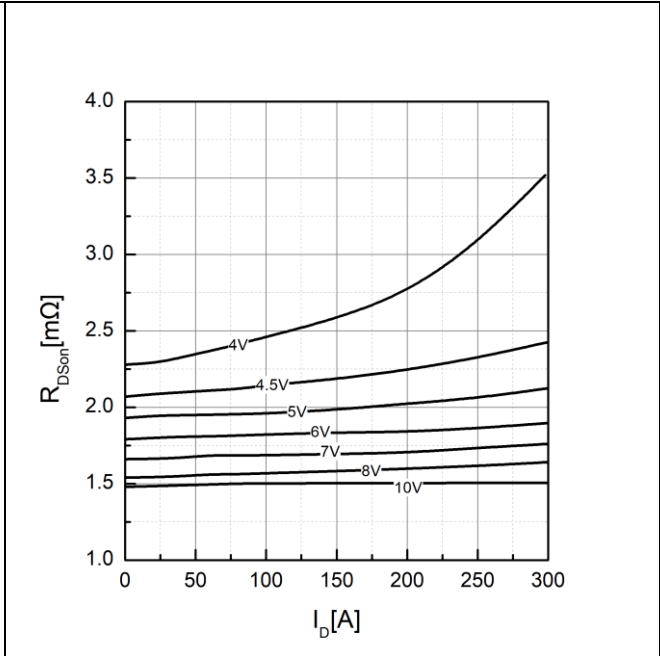
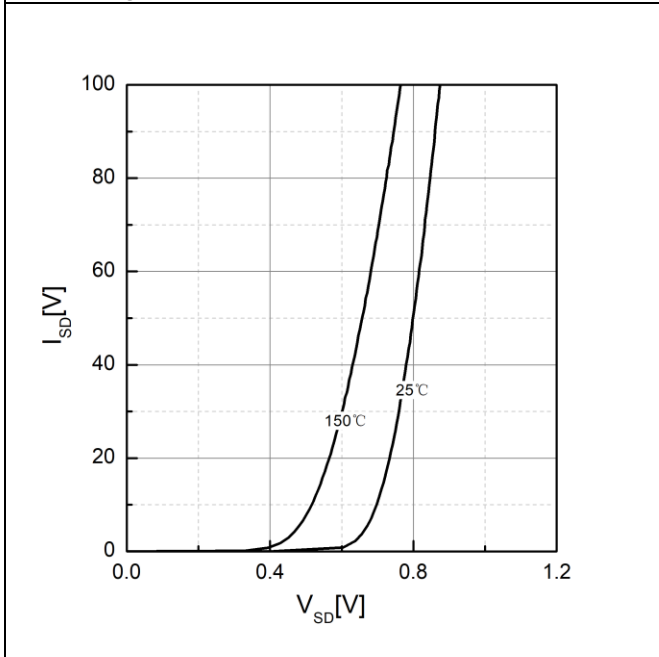
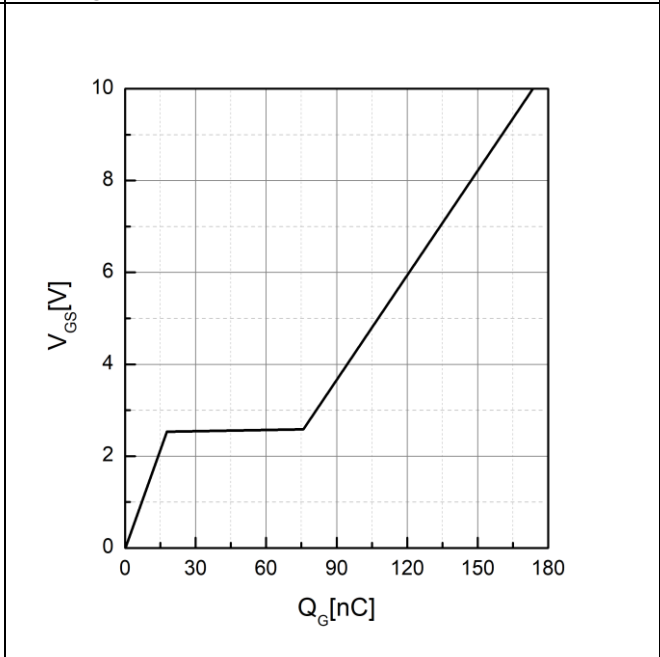
Symbol	Parameter	Max.	Units
$V_{DS}$	Drain-Source Voltage	45	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current, $V_{GS} @ 10V$ <sup>note1</sup>	$T_C = 25^\circ C$	225
		$T_C = 100^\circ C$	142
$I_{DM}$	Pulsed Drain Current <sup>note2</sup>	900	A
$P_D$	Power Dissipation <sup>note4</sup>	$T_C = 25^\circ C$	138
	Power Dissipation	$T_A = 25^\circ C$	3.12
$E_{AS}$	Single Pulsed Avalanche Energy <sup>note3</sup>	415	mJ
$R_{\theta JC}$	Thermal Resistance, Junction to Case <sup>note1</sup>	0.9	$^\circ C/W$
$R_{\theta JA}$	Junction to Ambient (mounted on 1 inch square PCB)	40	$^\circ C/W$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ C$

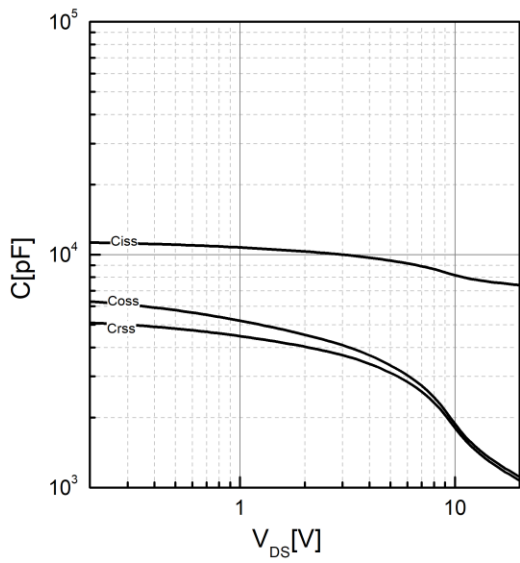
**Electrical Characteristics**  $T_C=25^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
<b>Off Characteristic</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	45	-	-	V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS} = 45V, V_{GS} = 0V, T_C = 25^{\circ}\text{C}$	-	-	1	$\mu A$
		$V_{DS} = 45V, V_{GS} = 0V, T_C = 55^{\circ}\text{C}$	-	-	10	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-100	-	100	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.0	-	2.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance <small>note2</small>	$V_{GS} = 10V, I_D = 20A$	-	1.5	1.8	m $\Omega$
		$V_{GS} = 4.5V, I_D = 20A$	-	2.0	2.4	m $\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 10V, I_D = 20A$		88	-	S
<b>Dynamic Characteristics</b>						
$R_g$	Gate Resistance		-	1.43	-	$\Omega$
$C_{iss}$	Input Capacitance	$V_{DS} = 20V, V_{GS} = 0V,$ $f = 1\text{MHz}$	-	7410	-	pF
$C_{oss}$	Output Capacitance		-	1110	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	1070	-	pF
$Q_g$	Total Gate Charge	$V_{DS} = 20V, I_D = 20A,$ $V_{GS} = 10V$	-	173	-	nC
$Q_{gs}$	Gate-Source Charge		-	17.7	-	nC
$Q_{gd}$	Gate-Drain("Miller") Charge		-	58	-	nC
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 20V, I_D = 20A,$ $R_G = 1\Omega, V_{GS} = 10V$	-	40	-	ns
$t_r$	Turn-On Rise Time		-	90	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	180	-	ns
$t_f$	Turn-Off Fall Time		-	114	-	ns
<b>Source-Drain Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Diode Forward Current <small>note1,5</small>		-	-	115	A
$I_{SM}$	Maximum Pulsed Diode Forward Current <small>note2,5</small>		-	-	900	A
$t_{rr}$	Reverse Recovery Time	$T_J = 25^{\circ}\text{C}, I_S = 20A, V_{GS} = 0V$	-	80	-	ns
$Q_{rr}$	Reverse Recovery Charge	$T_J = 25^{\circ}\text{C}, I_S = 20A,$ $di/dt = 100A/\mu s$		128		nC
$V_{SD}$ <small>note2</small>	Source to Drain Diode Forward Voltage	$T_J = 25^{\circ}\text{C}, I_S = 20A, V_{GS} = 0V$	-	0.75	-	V

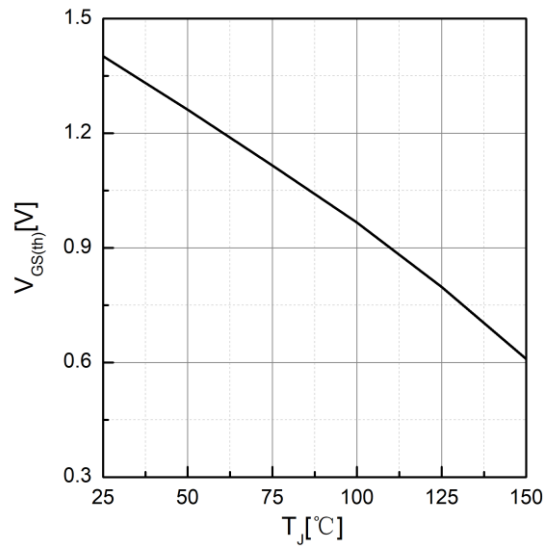
Note :

- 1.The data tested by surface mounted on one inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
- 3.The EAS data shows Max. rating. The test condition is  $L=0.1\text{mH}$ ,  $I_{AS}= 91.1\text{ A}$ .
- 4.The power dissipation is limited by  $150^{\circ}\text{C}$  junction temperature.
- 5.The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

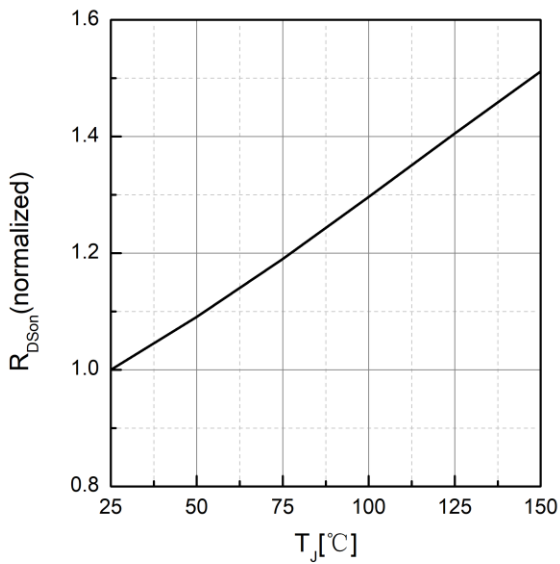
**Typical Performance Characteristics**

**Figure 1. Output Characteristics,  $T_J=25^\circ\text{C}$** 

**Figure 2. Drain-source on resistance,  $T_J=25^\circ\text{C}$** 

**Figure 3. Forward characteristics of body diode**

**Figure 4. Gate Charge Characteristics**



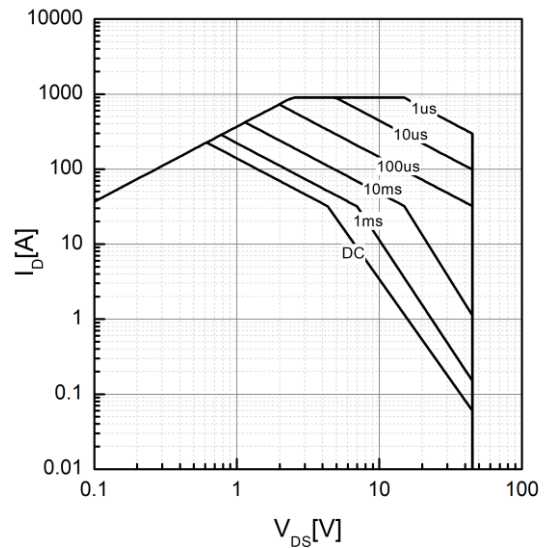
**Figure 5. Capacitance Characteristics**



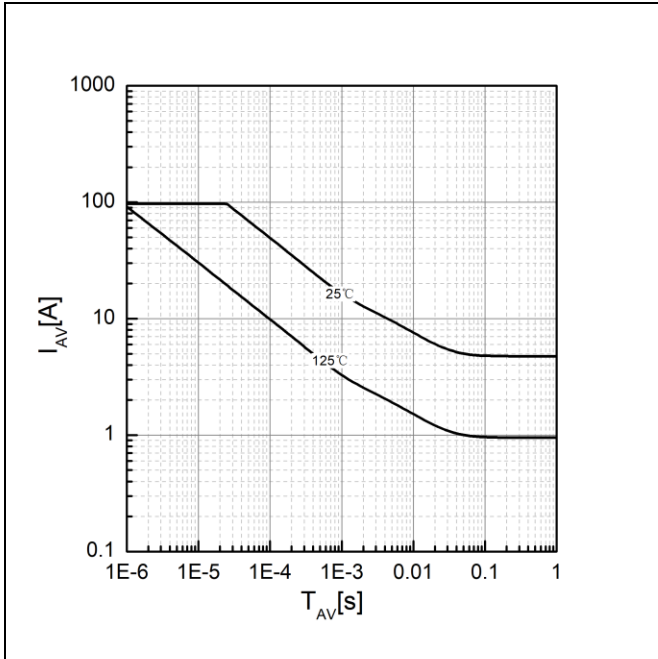
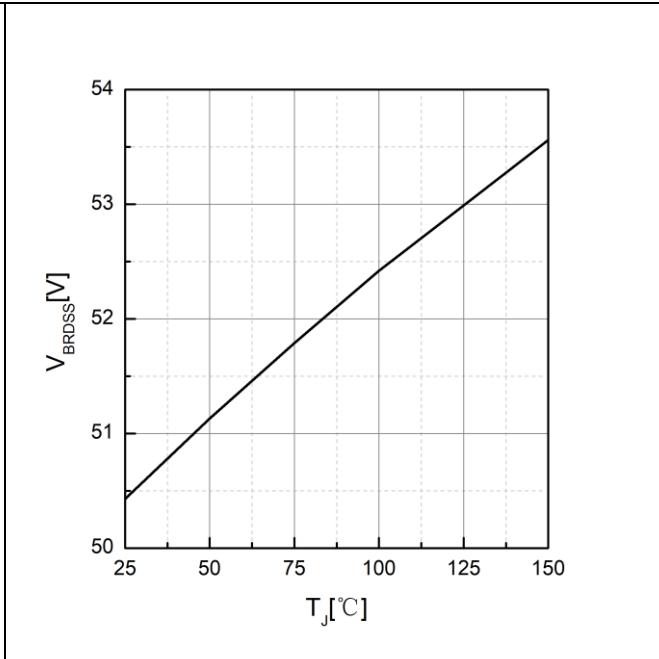
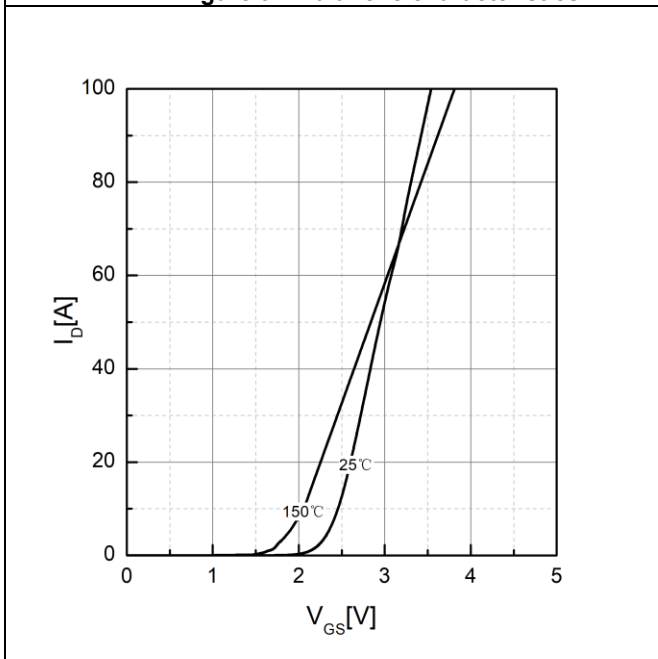
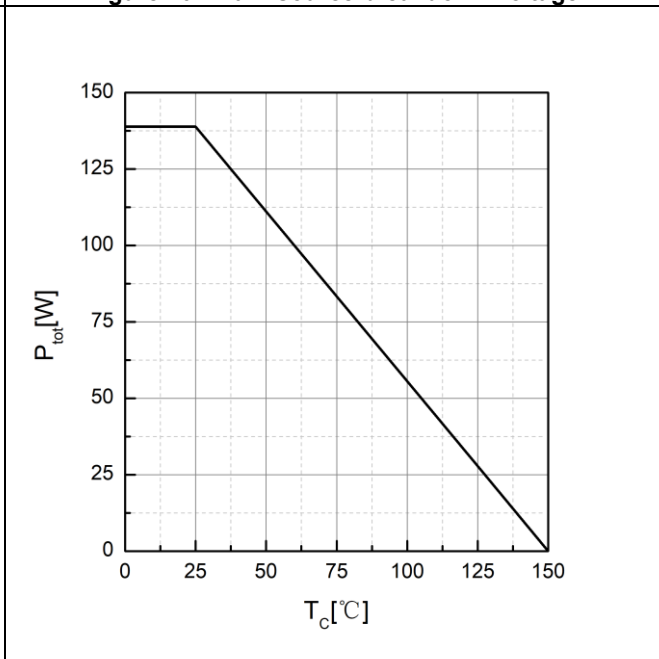
**Figure 6. Threshold Voltage Vs. Temperature**



**Figure 7. Drain-source on-state resistance**



**Figure 8. Maximum Safe Operating Area**


**Figure 9. Avalanche characteristics**

**Figure 10. Drain-source breakdown voltage**

**Figure 11. Transfer characteristics**

**Figure 12. Power dissipation**

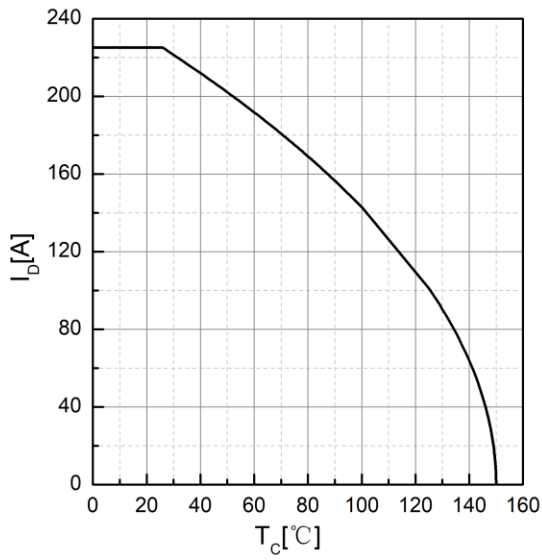


Figure 13. Drain current

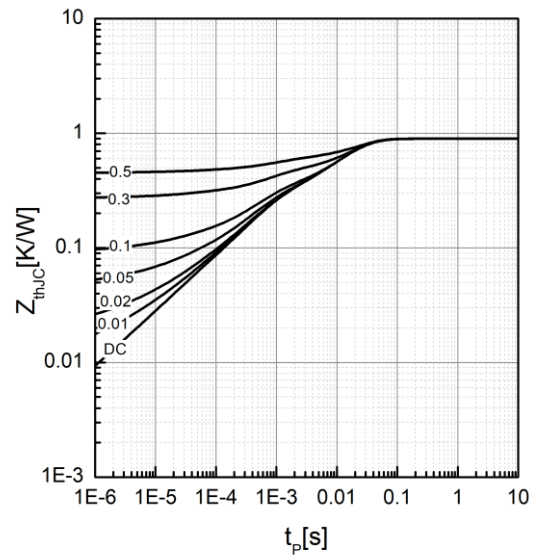


Figure 14. Effective Transient Thermal Impedance

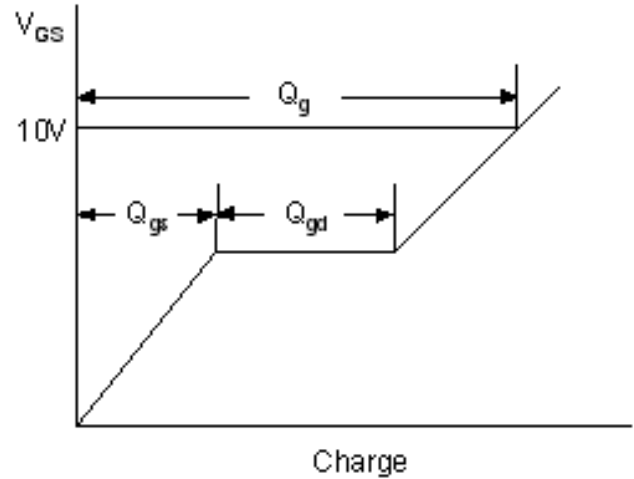
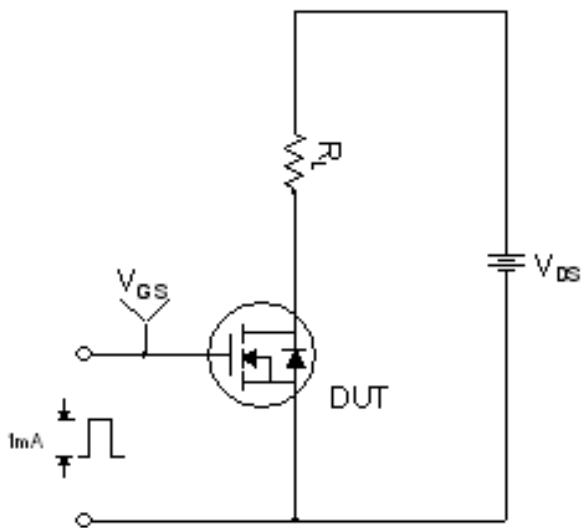
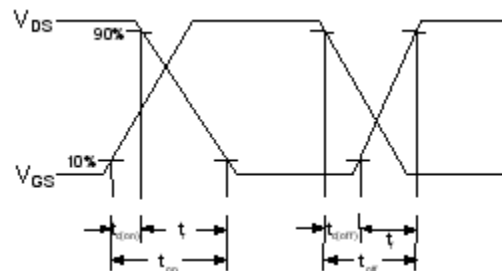
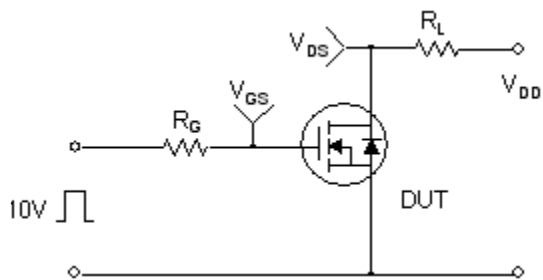
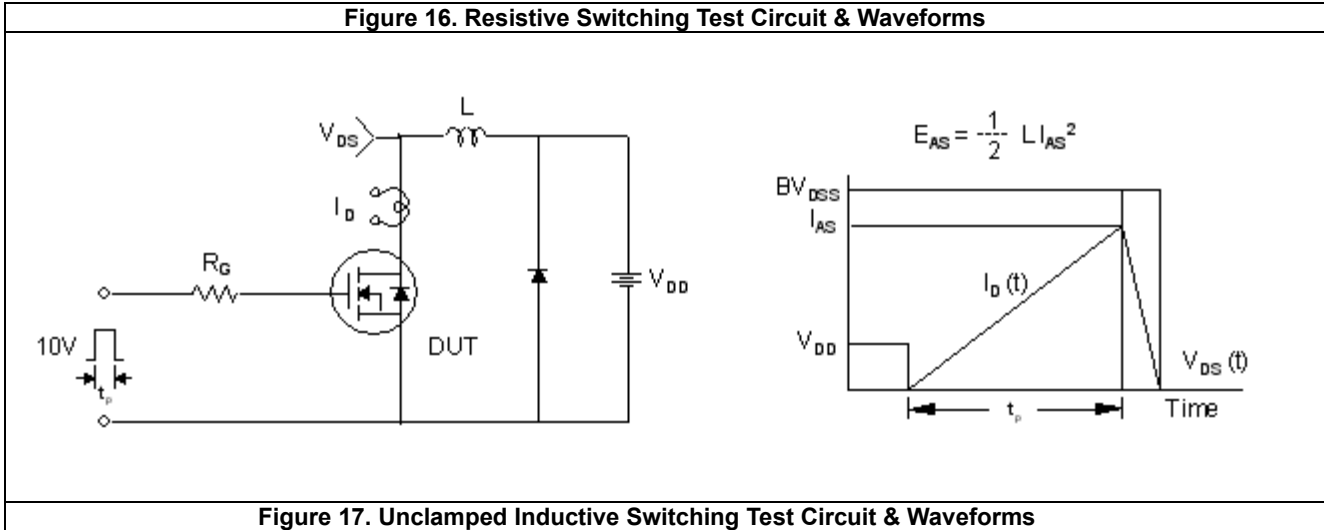


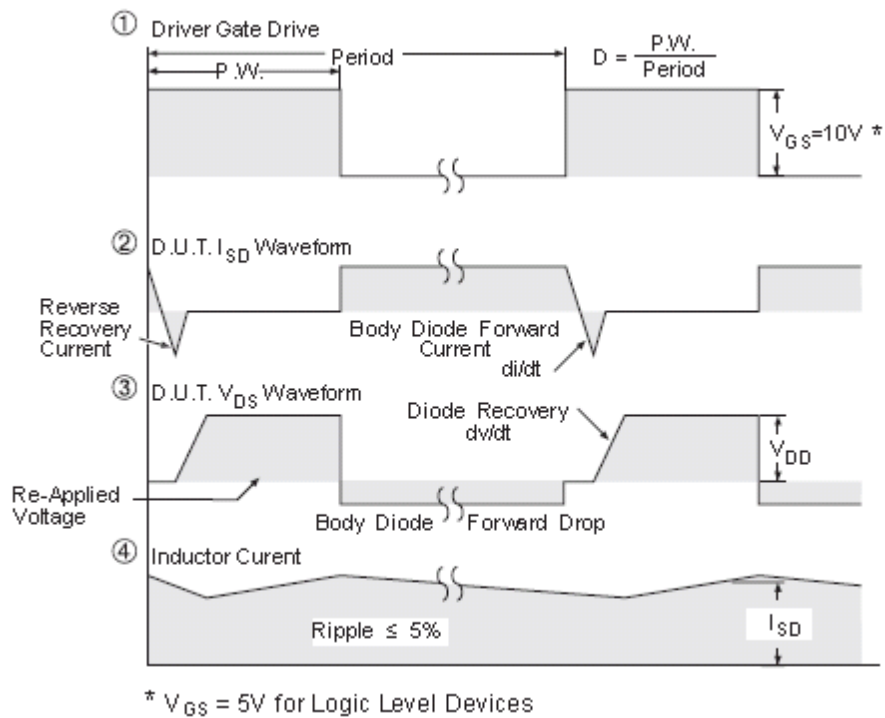
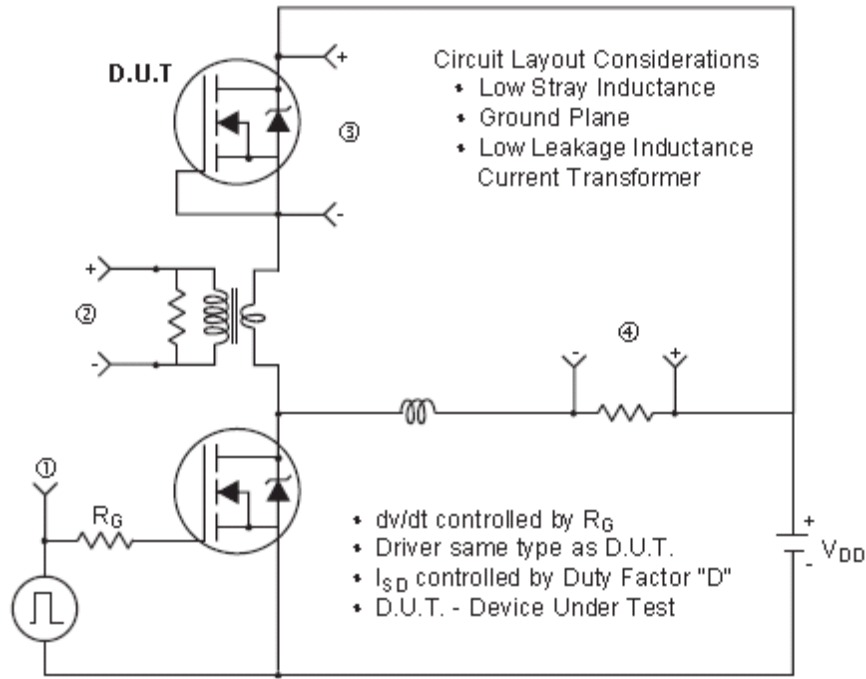
Figure 15. Gate Charge Test Circuit & Waveform



**Figure 16. Resistive Switching Test Circuit & Waveforms**

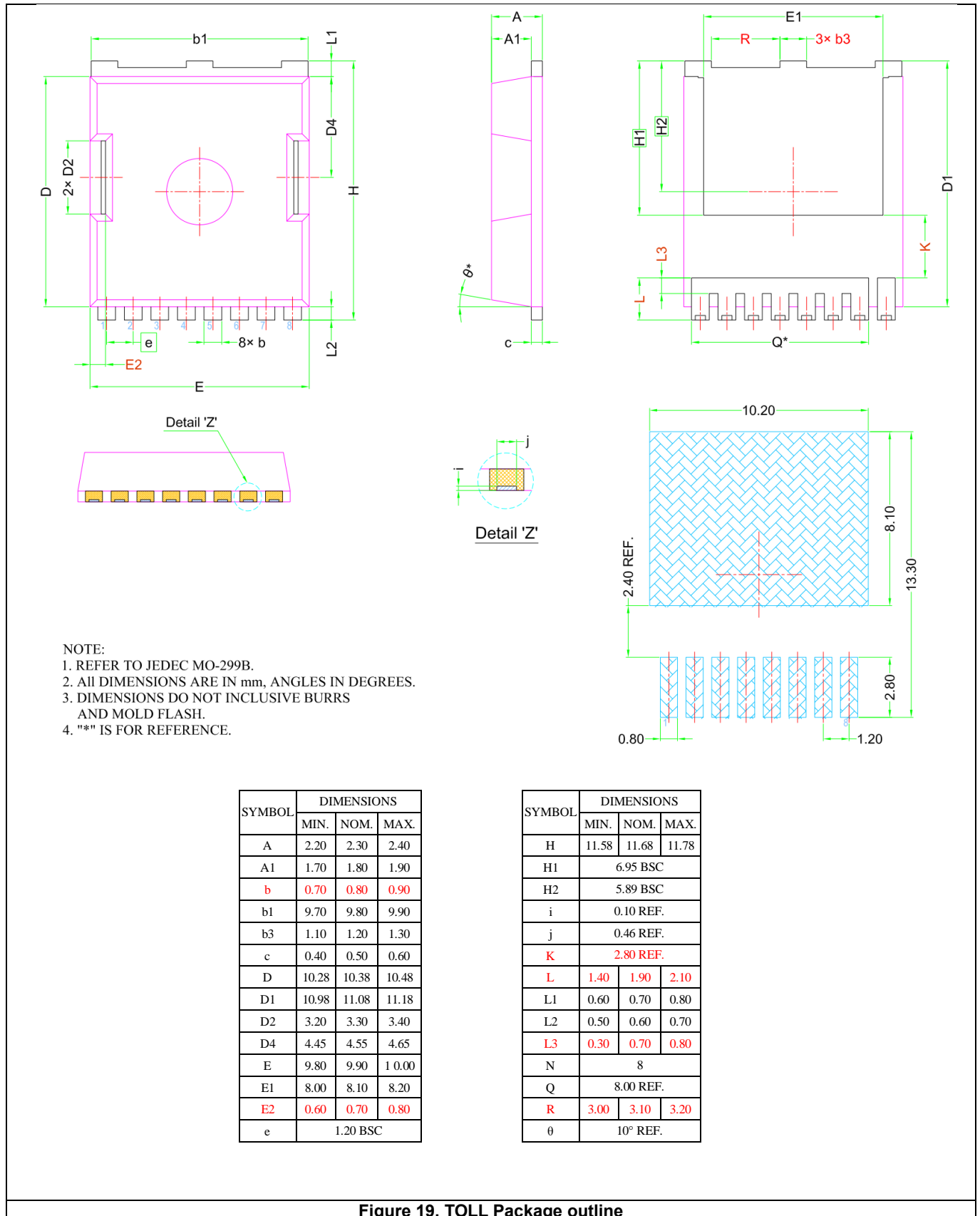


**Figure 17. Unclamped Inductive Switching Test Circuit & Waveforms**



**Figure 18. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms (For N-channel)**



**Package outline**

**Figure 19. TOLL Package outline**

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